10/043065

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Leonard Forbes

Examiner:

Group Art Unit:

Kiesha L Rose

Serial No.:

10/043,065

2822

Filed:

January 09, 2002

Docket:

303.684US3

Title:

P-CHANNEL DYNAMIC FLASH MEMORY CELLS WITH ULTRATHIN

TUNNEL OXIDES

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

In compliance with the duty imposed by 37 C.F.R. § 1.56, and in accordance with 37 C.F.R. §§ 1.97 et. seq., the enclosed materials are brought to the attention of the Examiner for consideration in connection with the above-identified patent application. Applicant respectfully requests that this Information Disclosure Statement be entered and the documents listed on the attached Form 1449 be considered by the Examiner and made of record. Pursuant to the provisions of MPEP 609, Applicant requests that a copy of the 1449 form, initialed as being considered by the Examiner, be returned to the Applicant with the next official communication.

Pursuant to 37 C.F.R. §1.97(b), it is believed that no fee or statement is required with the Information Disclosure Statement. However, if an Office Action on the merits has been mailed, the Commissioner is hereby authorized to charge the required fees to Deposit Account No. 19-0743 in order to have this Information Disclosure Statement considered.

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Page 2 Dki: 303.684US3

The Examiner is invited to contact the Applicant's Representative at the below-listed telephone number if there are any questions regarding this communication.

Respectfully submitted,

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CERTIFICATE UNDER 37 CFR 1.8: The undersigned hereby certifies that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail, in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on this 15 day of March, 2004.

Name

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Application Numb r	10/043065			
Filing Date	January 9, 2002			
First Named Inv ntor	Forbes, Leonard			
Gr up Art Unit	2822			
Examiner Name	Rose, Kiesha			
Attorney Docket No: 3	03.684US3			
	Filing Date First Named Inv ntor Gr up Art Unit Examiner Name			

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INFORMATION DISCLOSURE	Application Number	10/043065		
STATEMENT BY APPLICANT (Use as many strongs as ricos)	Filing Date	January 9, 2002		
	First Named Inv ntor	Forbes, Leonard		
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My Man	Examiner Name	Rose, Kiesha		
Sheet 2 of 20 TRACE NICO	Attorney Docket No: 303.684US3			

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